




<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09728373	YEE ET AL.
	Examiner Kim, David S	Art Unit 2633

Notes	Date	Examiner
www.google.com - various combinations of the following terms: bandpass square law device diode low pass filter heterodyne envelope detector foschini greenstein coherent noncoherent garrett jacobson ask theory optical precision rectifier	11/5/2005	DSK
ieeexplore.ieee.org - various combinations of the following terms: foschini greenstein garrett jacobson dual-filter fsk influence laser optical ask heterodyne post-detection	11/5/2005	DSK
www.scirus.com - various combinations of the following terms: envelope detector low pass filter rectifiergarrett jacobson heterodyne theory	11/5/2005	DSK
scholar.google.com - various combinations of the following terms: envelope detector low pass filter heterodyne	11/5/2005	DSK
U.S. Patent and Trademark Office		Part of Paper No.: 11052005

<p align="center"><b>Searched</b></p> 	Application/Control No.  09728373	Applicant(s)/Patent Under Reexamination  YEE ET AL.
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<b>Class</b>	<b>Sub Class</b>	<b>Date</b>	<b>Examiner</b>
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